



EN 62479 TEST REPORT

On Behalf of

Shantou Shuoyin Technology Co.,Ltd

Wireless Headphone

Model No.: SY-T9

Prepared for : Shantou Shuoyin Technology Co.,Ltd
Address : Hengshan industrial area, Gurao town, Chaoyang district, Shantou,
Guangdong, China

Prepared By : Shenzhen PSI Testing Co., Ltd.
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TABLE OF CONTENT

Description	Page
1. General Information	5
1.1. Description of Device (EUT).....	5
1.2. EN 62479 Standard	6
1.3. Product Function and Intended Use	6
1.4. Test Lab information	6
2. Limit	7
2.1. Basic Restrictions Reference levels	7
2.2. Limit calculations for radiated electric field strength measurement	9
2.3. Limit for Low-power exclusion level (Pmax).....	10
3. Test Results	11
3.1. Compliance Criteria.....	11



TEST REPORT DECLARATION

Applicant : Shantou Shuoyin Technology Co.,Ltd
Address : Hengshan industrial area, Gurao town, Chaoyang district, Shantou, Guangdong, China
Manufacturer : Shantou Shuoyin Technology Co.,Ltd
Address : Hengshan industrial area, Gurao town, Chaoyang district, Shantou, Guangdong, China
EUT Description : Wireless Headphone
(A) Model No. : SY-T9
(B) Trademark : /

Measurement Standard Used:

EN 62479:2010

Test Result: PASS

The device described above is tested by Shenzhen PSI Testing Co., Ltd. The measurement results are contained in this test report and Shenzhen PSI Testing Co., Ltd. is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the EN 62479 requirements.

This report applies to above tested sample only. This report shall not be reproduced in parts without written approval of Shenzhen PSI Testing Co., Ltd.

Tested by (name + signature).....: Jensen Wang
Test Engineer
Jensen Wang

Approved by (name + signature).....: Simple Guan
Project Manager
Simple Guan

Date of issue.....: November 30, 2024

Revision History

Revision	Issue Date	Revisions	Revised By
V0	November 30, 2024	Initial released Issue	Jensen Wang



1. General Information

1.1. Description of Device (EUT)

EUT Name : Wireless Headphone
Model No : SY-T9
DIFF. : N/A
Power supply : DC 5V from Adapter, DC 3.7V from Battery

Radio Technology : Bluetooth V5.3 EDR
Operation frequency : 2402-2480MHz
Channel No. : 79 channels
Channel Spacing : 1MHz
Modulation : GFSK, $\pi/4$ -DQPSK, 8DPSK
Antenna Type : Internal antenna, Maximum Gain is 0dBi.

Software version : V1.0

Hardware version : V1.0

Note : Antenna information is provided by applicant.
Testing lab is not responsible for the accuracy of the information.

1.2. EN 62479 Standard

EN 62479:2010 Assessment of the compliance of low power electronic and electrical equipment with the basic restrictions related to human exposure to electromagnetic fields (10 MHz to 300 GHz)

1.3. Product Function and Intended Use

The submitted sample is transmitter which declared transmitter channel frequency 2400-2483.5MHz.

1.4. Test Lab information

Shenzhen PSI Testing Co., Ltd.

1-2/F., Building 5, Yudafu Industrial Park, No.10, Xingye West Road, Shajing Subdistrict, Bao'an District, Shenzhen, Guangdong, China



2. Limit

2.1. Basic Restrictions Reference levels

Council Recommendation 99/519/EC Annex II

Basic restrictions for electric, magnetic and electromagnetic fields (0Hz to 300GHz)

Frequency range	Magnetic flux density (mT)	Current density (Ma/m ²) (rms)	Whole body average SAR (W/kg)	Localised SAR (head and trunk) (W/kg)	Localised SAR (limbs) (W/kg)	Power density, S (W/m ²)
0Hz	40	-	-	-	-	-
>0-1Hz	-	8	-	-	-	-
1-4Hz	-	8/f	-	-	-	-
4-1000Hz	-	2	-	-	-	-
1000Hz-100kHz	-	f/500	-	-	-	-
100kHz-10MHz	-	f/500	0.08	2	4	-
10MHz-10GHz	-	-	0.08	2	4	-
10-300GHz	-	-	-	-	-	10

Note:

(1)f is the frequency in Hz.

(2)The basic restriction on the current density is intended to protect against acute exposure effects on central nervous system tissues in the head and trunk of the body and includes a safety factor. The basic restrictions for ELF fields are based on established adverse effects on the central nervous system. Such acute effects are essentially instantaneous and there is no scientific justification to modify the basic restrictions for exposure of short duration. However, since the basic restriction refers to adverse effects on the central nervous system, this basic restriction may permit higher current densities in body tissues other than the central nervous system under the same exposure conditions.

(3)Because of electrical inhomogeneity of the body, current densities should be averaged over a cross section of 1cm² perpendicular to the current direction.

(4)For frequencies up to 100 kHz, peak current density values can be obtained by multiplying the rms value by $\sqrt{2}$ (=1.414). For pulses of duration t_p the equivalent frequency to apply in the basic restrictions should be calculated as $f=1/(2t_p)$

(5)For frequencies up to 100kHz and for pulsed magnetic fields, the maximum current density associated with the pulses can be calculated from the rise/fall times and the maximum rate of change of magnetic flux density. The induced current density can then be compared with the appropriate basic restriction.

(6)All SAR values are to be averaged over any six-minute period.

(7) Localised SAR averaging mass is any 10g of contiguous tissue; the maximum SAR so obtained should be the value used for the estimation of exposure. These 10g of tissue are intended to be a mass of contiguous tissue with nearly homogeneous electrical properties. In specifying a contiguous mass of tissue, it is recognised that this concept can be used in computational dosimetry but may present difficulties for direct physical measurements. A simple geometry such as cubic tissue mass can be used provided that the calculated dosimetric quantities have conservation values relative to the exposure guidelines.

(8) For pulses of duration t_p the equivalent frequency to apply in the basic restrictions should be calculated as $f=1/(2t_p)$. Additionally, for pulsed exposures, in the frequency range 0,3 to 10GHz and for localised exposure of the head, in order to limit and avoid auditory effects caused by thermoelastic expansion, an additional basic restriction is recommended. This is that SA should not exceed 2mJ kg⁻¹ averaged over 10g of tissue.

Reference Levels

Council Recommendation 99/519/EC Annex III

Reference levels for electric, magnetic and electromagnetic fields (0Hz to 300GHz)

Frequency range	E-field strength (V/m)	H-field strength (A/m)	B-field (μT)	Equivalent plane wave power density Seq (W/m ²)
0-1Hz	-	$3,2 \times 10^4$	4×10^4	-
1-8Hz	1000	$3,2 \times 10^4 / f^2$	$4 \times 10^4 / f^2$	-
8-25Hz	1000	$4000 / f$	$5000 / f$	-
0.025Hz-0,8kHz	$250 / f$	$4 / f$	$5 / f$	-
0,8-3kHz	$250 / f$	5	6,25	-
3-150kHz	87	5	6,25	-
0,15-1MHz	87	$0,73 / f$	$0,92 / f$	-
1-10MHz	$87 / f^{1/2}$	$0,73 / f$	$0,92 / f$	-
10-400MHz	28	0.073	0,092	2
400-2000MHz	$1,375 f^{1/2}$	$0,0037 f^{1/2}$	$0,0046 f^{1/2}$	$f / 200$
2-300GHz	61	0,16	0,20	10

Note: 1) As indicated in the frequency range column.

(2) For frequencies between 100kHz and 10GHz, Seq, E2, H2 and B2 are to be averaged over any six-minute period.

(3) For frequencies exceeding 10GHz, Seq, E2, H2 and B2 are to be averaged over any 68/1.05-minute period (.in GHz).

(4) No E-field value is provided for frequencies <1Hz, which are effectively static electric fields. For most people the annoying perception of surface electric charges will not occur at field strengths less than 20kV/m. Spark discharges causing stress or annoyance should be avoided.

2.2. Limit calculations for radiated electric field strength measurement

For the calculation of the limits, the near field proportionality factor $1/d^3$ has been used. For ten times the distance, the level is decreased by the cubical, giving 60 dB.

Frequency range	Limit V/m @ 0.3m	Limit V/m @ 3m	Limit (add. span)
30 MHz – 400 MHz	28 V/m (149 dB μ V/m)	89 dB μ V/m	69 dB μ V/m
400 MHz – 2 GHz	27.5 V/m – 61.5 V/m (149 dB μ V/m – 155 dB μ V/m)	89 dB μ V/m	69 dB μ V/m
		95 dB μ A/m	75 dB μ V/m
2 GHz – 300 GHz	61 V/m (155 dB μ V/m)	95 dB μ V/m	75 dB μ V/m

To deal with reflexions, other effects due to the measurement in 3 m distance and to deal with a measurement uncertainty of at least 5 dB, an additional span of 20 dB has been added.

For additional three times the distance, the level is decreased by additional 30 dB.

Frequency range	Limit V/m @ 0.1m	Limit V/m @ 3m	Limit (add. span)
30 MHz – 400MHz	28 V/m (149 dB μ V/m)	59 dB μ V/m	39 dB μ V/m
400 MHz – 2 GHz	27.5 V/m – 61.5 V/m (149 dB μ V/m – 155 dB μ V/m)	59 dB μ V/m	39 dB μ V/m
		65 dB μ A/m	45 dB μ V/m
2 GHz – 300 GHz	61 V/m (155 dB μ V/m)	65 dB μ V/m	45 dB μ V/m

To deal with reflexions, other effects due to the measurement in 3 m distance and to deal with a measurement uncertainty of at least 5 dB, an additional span of 20 dB has been added.

Limits for radiated field according to EN 55032 / CISPR 32 for a class B appliance:

Frequency range	Limit dB μ V/m @ 3m Peak	Limit dB μ V/m @ 3m QP or Average
30 MHz – 230MHz		40 dB μ V/m quasi-peak
230 MHz – 1 GHz		47 dB μ V/m quasi-peak
1 GHz – 3 GHz	70 dB μ V/m peak	50 dB μ V/m average
3 GHz – 6 GHz	74 dB μ V/m peak	54 dB μ V/m average

Conclusion: If the requirements for radiated emissions according to EN 55032 / CISPR 32 or other standards with the same limits are fulfilled, also the EMF requirements for the measured frequency range are fulfilled

2.3. Limit for Low-power exclusion level ($P_{\max}$)

When SAR is the basic restriction, a conservative minimum value for $P_{\max}$ can be derived, equal to the localized SAR limit ($SAR_{\max}$) multiplied by the averaging mass (m):

$P_{\max} = SAR_{\max} m$ (A.1) Example values of $P_{\max}$ according to Equation (A.1) are provided in Table A.1 for cases described by the ICNIRP guidelines [1], IEEE Std C95.1-1999 [2] and IEEE Std C95.1-2005 [3] where SAR limits are defined. Other exposure guidelines or standards may be applicable depending on national regulations.

Table A.1 – Example values of SAR-based $P_{\max}$ for some cases described by ICNIRP, IEEE Std C95.1-1999 and IEEE Std C95.1-2005

Guideline / Standard	SAR limit, $SAR_{\max}$ W/kg	Averaging mass, m g	$P_{\max}$ mW	Exposure tier ^a	Region of body ^a
ICNIRP [1]	2	10	20	General public	Head and trunk
	4	10	40	General public	Limbs
	10	10	100	Occupational	Head and trunk
	20	10	200	Occupational	Limbs
IEEE Std C95.1-1999 [2]	1,6	1	1,6	Uncontrolled environment	Head, trunk, arms, legs
	4	10	40	Uncontrolled environment	Hands, wrists, feet and ankles
	8	1	8	Controlled environment	Head, trunk, arms, legs
	20	10	200	Controlled environment	Hands, wrists, feet and ankles
IEEE Std C95.1-2005 [3]	2	10	20	Action level	Body except extremities and pinnae
	4	10	40	Action level	Extremities and pinnae
	10	10	100	Controlled environment	Body except extremities and pinnae
	20	10	200	Controlled environment	Extremities and pinnae
^a Consult the appropriate standard for more information and definitions of terms.					

3. Test Results

3.1. Compliance Criteria

From results of report psi2411155-C01-R05 can be assumed that the compliance criteria is fulfilled (max. radiated power is less than 10mW). The assumption is made with an uncertainty of 30%.

EN 62479: 2010"4.2 Low-power exclusion level (Pmax)

Low-power electronic and electrical equipment is deemed to comply with the provisions of this standard if it can be demonstrated using routes B, C or D that the available antenna power and/or the average total radiated power is less than or equal to the applicable low-power exclusion level Pmax. Annex A contains example values for Pmax derived from existing exposure limits listed in the bibliography, such as the ICNIRP guidelines [1], IEEE Std C95.1-1999 [2], and IEEE Std C95.1-2005 [3].

Frequency range	Maximum output power(dBm)	Maximum output power(mW)	Limit (mW)	Conclusion
Bluetooth EDR	4.24	2.655	20	Pass
Note: Output power value refers to the report psi2411155-C01-R05.				

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